

**Search Notes**

Application/Control No.

10/809,725

Examiner

Rene Towa

Applicant(s)/Patent under  
Reexamination

CHAN, FRANK A.

Art Unit

3736

**SEARCHED**

Class	Subclass	Date	Examiner
600	573	4/13/2006	RTT
600	576	4/13/2006	RTT
600	583	4/13/2006	RTT
606	181	4/13/2006	RTT
606	182	4/13/2006	RTT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
SEE SEARCH HISTORY	4/13/2006	RTT